

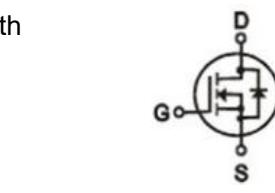


• General Description

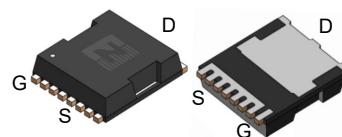
It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance



$V_{DS} = 40V$
 $R_{DS(ON)} = 0.5m\Omega$
 $I_D = 360A$



• Application

- BLDC Motor driver
- DC-DC
- Load Switch

• Ordering Information:

Part NO.	ZMS005N04HR
Marking	ZMS005N04H
Packing Information	REEL TAPE
Basic ordering unit (pcs)	2000

• Absolute Maximum Ratings ($T_C=25^\circ C$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		40	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ C$ (silicon limited)	445	A
	I_D	$T_C=25^\circ C$ (package limited)	360	A
	I_D	$T_C=100^\circ C$	282	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu s$; $T_{mb} = 25^\circ C$	1780	A
Total Power Dissipation	P_D	$T_C=25^\circ C$	313	W
Total Power Dissipation	P_D	$T_A=25^\circ C$	3.5	W
Operating Junction Temperature	T_J		-55 to +150	$^\circ C$
Storage Temperature	T_{STG}		-55 to +150	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1mH$, $VGS=10V$, $Rg=25\Omega$,	756	mJ
		$L=0.5mH$, $VGS=10V$, $Rg=25\Omega$,	1210	mJ
ESD Level (HBM)			CLASS 2	



•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	0.4	°C/W
Thermal resistance, junction-ambient	R _{thJA} ^①		-	36	°C/W
Soldering temperature	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	40			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	2	2.7	4	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = 40V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D = 40A		0.5	0.75	mΩ
Forward Transconductance	g _{FS}	V _{GS} =5V, I _{SD} = 10A		30		s
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = 40A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =25V	-	10620	-	pF
Output capacitance	C _{oss}		-	2810	-	
Reverse transfer capacitance	C _{rss}		-	115	-	
Gate Resistance	R _g	f = 1MHz	-	1.6		Ω
Total gate charge	Q _g	V _{DD} = 15V, I _D = 20A, V _{GS} = 10V	-	155	-	nC
Gate - Source charge	Q _{gs}		-	35	-	
Gate - Drain charge	Q _{gd}		-	32	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =10V, V _{DS} =15V, R _G =3.3Ω, I _D =20A	-	65	-	ns
Turn-ON Rise time	t _r		-	31	-	ns
Turn-Off Delay time	t _{D(off)}		-	85	-	ns
Turn-Off Fall time	t _f		-	78	-	ns
Reverse Recovery Time	t _{RR}	V _{DD} =20V, dI _S /dt = 100A/us, I _S =50A	-	97	-	ns
Reverse Recovery Charge	Q _{RR}		-	135	-	nC



Fig.1 Gate-Charge Characteristics

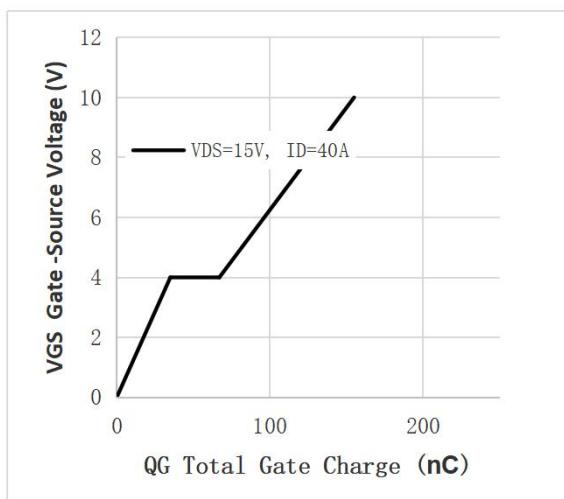


Fig.2 Capacitance Characteristics

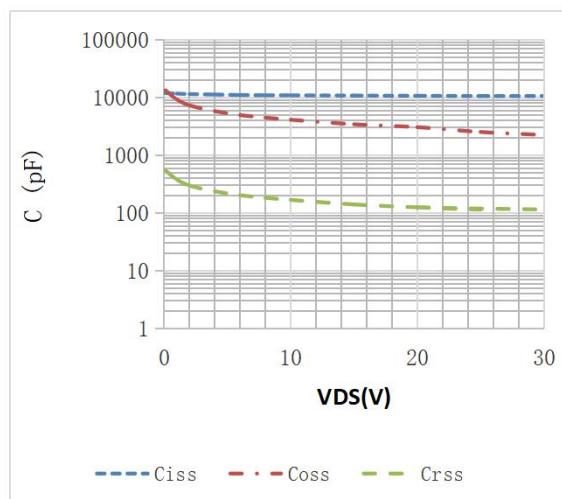


Fig.3 Power Dissipation

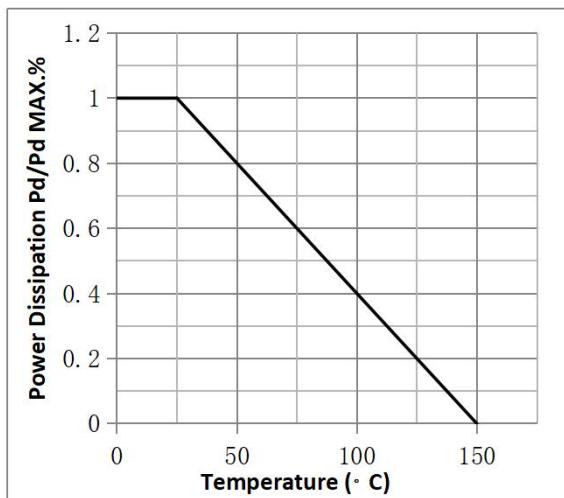


Fig.4 Typical output Characteristics

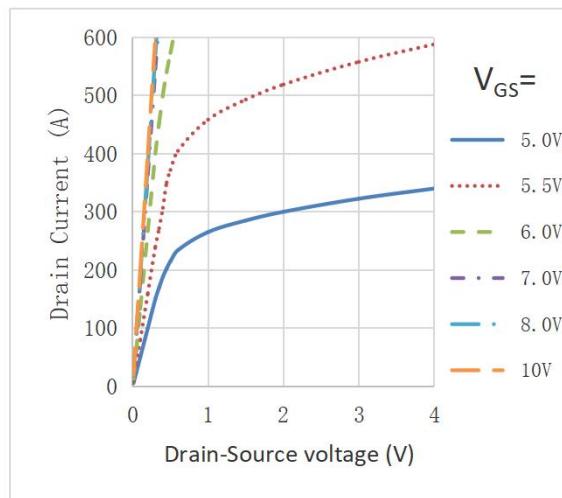


Fig.5 Threshold Voltage V.S Junction Temperature

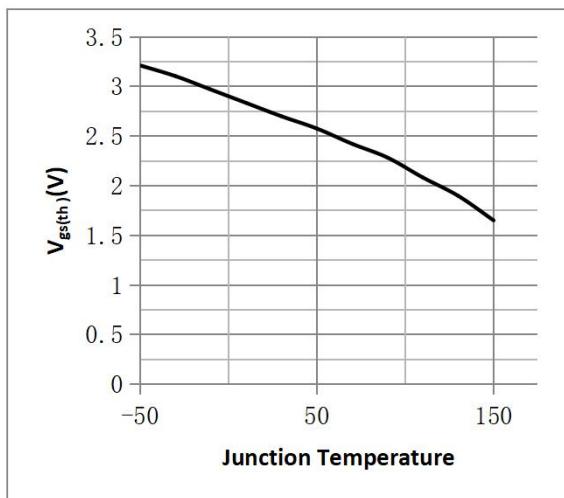


Fig.6 Resistance V.S Drain Current

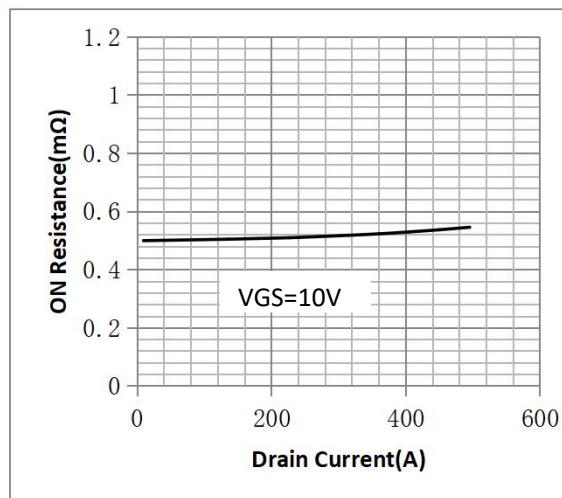


Fig.7 On-Resistance VS Gate Source Voltage

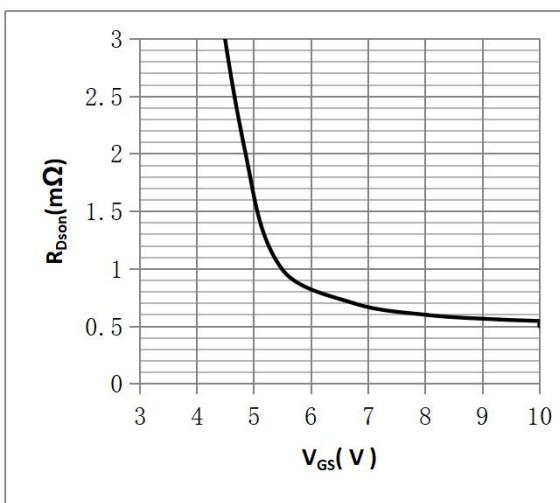


Fig.8 On-Resistance V.S Junction Temperature

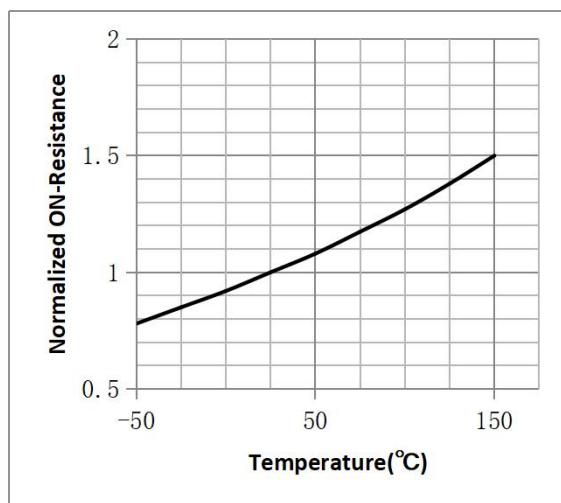


Figure 9. Diode Forward Voltage vs. Current

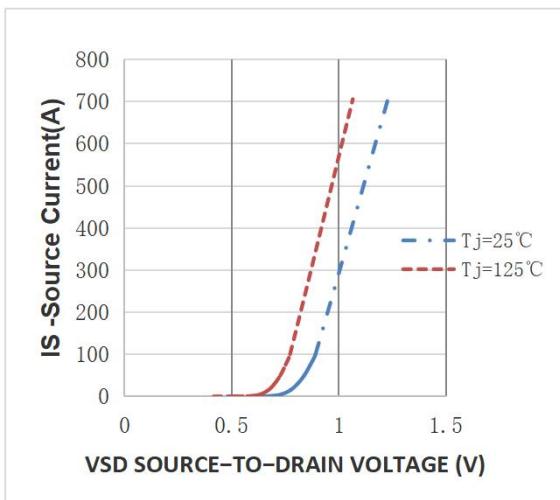


Figure 10. Transfer Characteristics

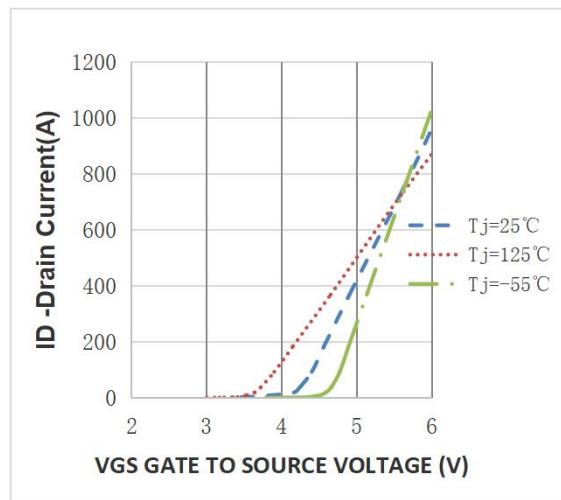
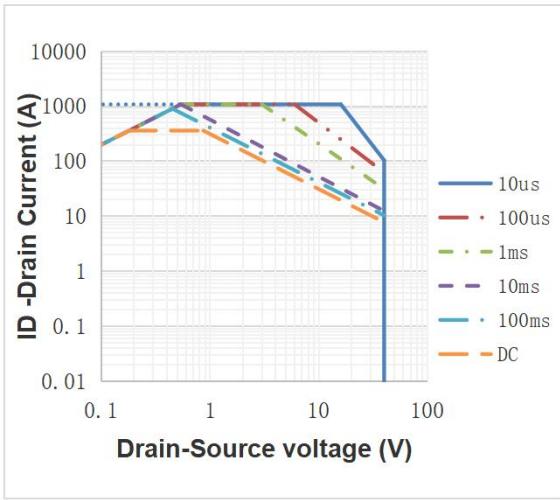
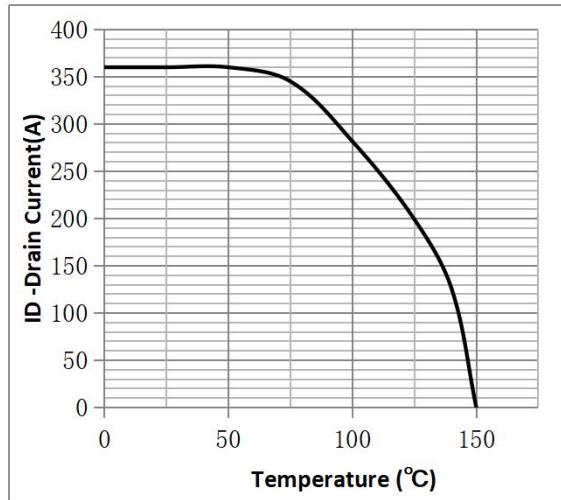
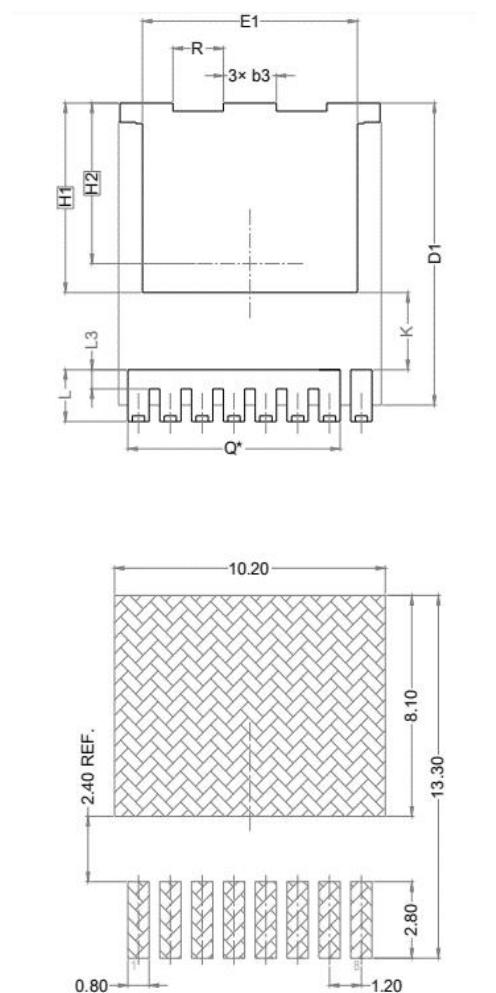
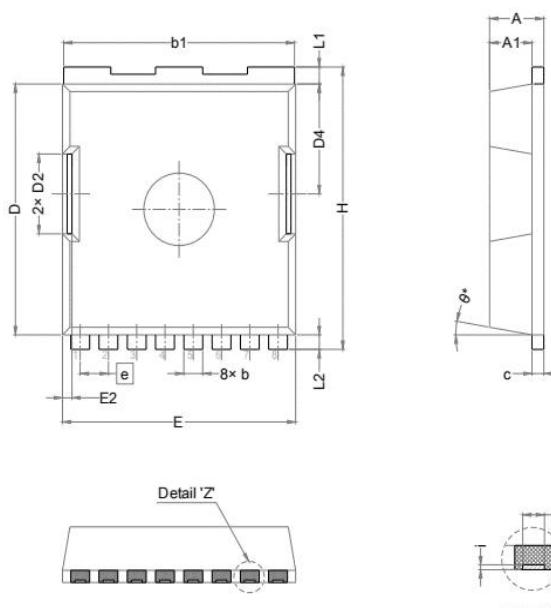


Fig.11 SOA Maximum Safe Operating Area

Fig.12 ID vs. Junction Temperature^②



•TOLL Package Outline



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b3	1.90	2.00	2.10
c	0.40	0.50	0.60
D	10.28	10.38	10.48
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D4	4.45	4.55	4.65
E	9.80	9.90	10.00
E1	8.00	8.10	8.20
E2	0.30	0.40	0.50
e	1.20 BSC		
H	11.58	11.68	11.78
H1	6.95 BSC		
H2	5.89 BSC		
i	0.10 REF.		
j	0.46 REF.		
K	2.80 REF.		
L	1.60	1.90	2.10
L1	0.60	0.70	0.80
L2	0.50	0.60	0.70
L3	0.60	0.70	0.80
N	8		
Q	6.80 REF.		
R	1.80	1.90	2.00
θ	10° REF.		

**Note:**

① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

② Practically the current will be limited by PCB, thermal design and operating temperature.
VGS=10V.

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Revision History

Version	Date	Change
A	2023.9.15	new